## Notice of References Cited Application/Control No. 09/873,786 Examiner Oanh L. Duong Applicant(s)/Patent Under Reexamination YEN ET AL. Page 1 of 1 U.S. PATENT DOCUMENTS

## Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-Α US-В US-С US-D US-Ε F US-US-G Н US-US-١ US-J US-Κ

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 01/22731 A1	.03-2001		Barrett et al.	H04N 7/16
	0					
	Р					
	Q				·	
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	٧						
	w						
	х						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

US-

US-

L M